

FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.: ST 10224SERIAL NO. 10/690,415

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT: WEBER, M. ET AL. - 4FILING DATE: 10/21/2003GROUP: 77651722

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
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	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
FH.	AL	<u>1644009</u>	<u>9/24/1970</u>	<u>Germany</u>				
FH.	AM	<u>WO 86/03523</u>	<u>6/19/1986</u>	<u>PCT</u>				
	AN							
	AO							
	AP							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

FH.	AR		<u>English Derwent Abstract AN 1975-69034 W</u>
			<u>corresponding to DE 000 1644009</u>
FH.	AS		<u>A. Trainor et P.T. Harris: "The control of Resistivity</u> <u>in Pulled Si Crystals" Proc. of Phys. Soc, London (1959), 74</u>
FH.	AT		<u>E. Schöne: "Über den Einfluß ..." (P. 5; No 479), p. 669-670.</u> <u>IHT-Mitteilungen I(3), 1962, pg. 46-49.</u>

EXAMINER

DATE CONSIDERED

12/20/2005

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

-FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. : <b>ST 10224</b>		SERIAL NO. <b>10/690,415</b>	
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				FILING DATE: <b>10/21/2003</b>		GROUP: <b>1765 1728</b>	
<b>U.S. PATENT DOCUMENTS</b>							
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FH	AR		Z. Liu et T. Carlberg: "A model for Dopant Conc. in Cz-Silicon Melts", J. Electrochem. Soc., Vol. 140, No. 7, July 1993				
FH	AS		W. Zulehner et D. Huber: "Czochralski-Grown Silicon", p. 26-38.				
FH	AT		T. Izumi: "Model analysis of segregation phenomena ...", J. of Crystal Growth 181 (1997), pg. 210-217.				
EXAMINER <i>for Alish</i>			DATE CONSIDERED <b>12/20/05</b>				
<small>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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	AN							
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	AP							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

F.H.	AR		ASTM: Designation: F723-99: "Standard Practice
			for Conversion ...", pg. 1-17.
	AS		
	AT		

EXAMINER

*E. H. H.*

DATE CONSIDERED

12/21/2005

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